Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination OHKAWA ET AL. Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,727,723	04-2004	Shimizu et al.	324/765
*	В	US-6,727,722	04-2004	Whetsel, Lee D.	324/765
*	O	US-6,512,392	01-2003	Fleury et al.	324/765
*	D	US-6,400,173	06-2002	Shimizu et al.	324/765
*	Ε	US-6,326,801	12-2001	Whetsel, Lee D.	324/765
*	F	US-5,506,516	04-1996	Yamashita et al.	324/770
	G	US-			, ·
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages))			
	U										
	٧										
	w										
	х										. •

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.